

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10663767	HIRAYAMA ET AL.
	<b>Examiner</b> Egan, Scott	<b>Art Unit</b> 2621

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
348	272-275, 280, 335, 340	12/13/06	SE
438	29, 31, 69	12/13/06	SE
257	432, 294	12/13/06	SE

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
East BRS see attached	12/13/06	SE
Spoke with Tuan Ho about moving Microlenses to collect light at different angles	12/13/06	SE

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>